Amino-Functionalized Alkylsilane SAM-Assisted Patterning of Poly(3-hexylthiophene) Nanofilm Robustly Adhered to SiO₂ Substrate

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We report a novel patterning method for a homo-polymeric poly(3-hexylthiophene) (P3HT) nanofilm particularly capable of strong adhesion to a SiO₂ surface. An oxidized silicon wafer substrate was micro-contact printed with n-octadecyltrichlorosilane (OTS) monolayer, and subsequently its negative pattern was self-assembled with three different amino-functionalized alkylsilanes, (3-aminopropyl)trimethoxysilane (APS), N-(2-aminoethyl)-3-aminopropyltrimethoxy silane (EDAS), and (3-trimethoxysilylpropyl) diethylenetriamine (DETAS). Then, P3HT nanofilms were selectively grown on the aminosilane pre-patterned areas via the vapor phase polymerization method. To evaluate the adhesion, patterning, and the film itself, the PEDOT nanofilms and SAMs were investigated with a Scotch® tape test, contact angle analyzer, ATR-FT-IR, and optical and atomic force microscopes. The evaluation showed that the newly developed all-bottom-up process can offer a simple and inexpensive patterning method for P3HT nanofilms robustly adhered to an oxidized Si wafer surface by the mediation of FeCl₃ and amino-functionalized alkylsilane SAMs.

Key Words : Poly(3-hexylthiophene), Amino-alkylsilane, Patterning, Vapor phase polymerization

Introduction

For decades, conductive π-conjugated polymers have fascinated many scientists since these substances have great potential for applicability to next-generation optoelectronic devices such as organic thin film transistors (OTFTs) and organic light emitting diodes (OLEDs). Among these polymers, poly(3-hexylthiophene) (P3HT) has received particular attention as an active layer or p-type transport layer of OTFT and OLED devices. Due to good solubility of P3HT in non-polar organic solvents, it can be easily prepared as a thin film using wet processes such as spin-coating and recrystallization. These methods are typically employed for integrating an active layer into an OTFT device. However, P3HT has not been very popular as electrode materials mainly due to unavailability of a good dopant as well as effective doping method. To overcome this drawback, a dry film-forming process of P3HT, i.e., a vapor phase polymerization (VPP) method, could be a good choice for effective doping. In the VPP method, monomers of a conducting polymer in a closed chamber can be vaporized simply via temperature elevation, and these molecules can be quickly self-assembled and easily polymerized on an oxidizing agent (as well as a dopant)-coated substrate, thereby producing a homo-polymer thin film. Via this method, our laboratory very recently demonstrated that a highly effectively FeCl₃-doped (~600 S/cm) poly(3,4-ethylenedioxythiophene) (PEDOT) nanofilm can be prepared as an electrode materials. Therefore, it is reasonable to believe that the VPP method could also offer an effectively doped P3HT electrode for an OTFT device.

Nonetheless, the application of a P3HT film to a conventional TFT fabrication process still has a couple of technical hurdles, too. They are the poor adhesion of the P3HT thin film to the oxide substrate and the lack of a scalable and inexpensive patterning method. Patterning of wet-processed P3HT films has typically depended on traditional and well-established subtractive techniques such as photolithography, which is expensive and complex. As an effort to resolve these problems, our laboratory recently developed an all-bottom-up patterning process via the combination of a self-assembly technique and VPP method. In this method, various amino-functionalized alkylsilane monolayers were self-assembled on the negative patterns of micro-contact printed OTS monolayers. Then, PEDOT nanofilms were selectively grown on the amino-functionalized alkylsilane monolayer via the VPP method. The films were characterized and it was discovered that the PEDOT nanofilms can be very effectively patterned on and that they robustly adhered to the oxide substrate most likely through direct chemical bonding. Therefore, in this work, we have also tried to prepare a highly effectively doped and selectively patterned P3HT nanofilm particularly capable of strong adhesion to SiO₂ surface via the combination of an alkylsilane self-assembly technique and VPP method.

Experimental Details

The main chemicals used in this study were 3HT (3-hexylthiophene, 99%, Aldrich, St. Louis, USA), OTS (n-Octadecyltrichlorosilane, 99%, Aldrich, St. Louis, USA), APS (3-Aminopropyl)trimethoxysilane, 97%, Aldrich Inc.,...
St. Louis, USA), EDAS (N-[2-Aminoethyl]-3-aminopropyltrimethoxysilane, 97%, Gelest Inc. USA), and DETAS (3-Trimethoxysilylpropyldiethylenetriamine, 97%, Gelest Inc. USA). All other chemicals and solvents were reagent grades (96-99% purity) and used as received.

The oxidized (100) Si wafer (1.5 cm × 1.5 cm) was soaked into a piranha solution for ten minutes and then rinsed with ultra-pure water to remove any organic contaminants that may adsorbed on the surface. A PDMS stamp was used for microcontact printing to transfer OTS SAM patterns onto the wafer substrate, thereby rendering the stamped area hydrophobic (water contact angle = ~110°). After the OTS printing, the negative pattern was coated with aminofunctionalized alkylsilane monolayers (APS, EDAS, and DETAS) by dipping it into the silane solution (0.1 mM silane + 1 μM acetic acid in 50 ml ethyl alcohol) for at least an hour. After rinsing it with ethyl alcohol and subsequent drying via N2 blowing, 3 (w/v)% FeCl3 was spread onto the monolayer surface and spun at 2500 rpm with a spin coater for 90 seconds. The mixed monolayer sample coated with the FeCl3 catalyst (dopant) was placed in a mechanical circulation oven (Yuyu Scientific Mfg. Co., Korea) including 3HT. The 3HT was vaporized for thirty minutes at 55 °C and immediately polymerized. Then, the polymer was selectively patterned on a Si wafer surface to form a P3HT film. The sample was always rinsed with methanol and then dried in a desiccator prior to the characterization.

All optical microscopic images in this study were taken with a PME 3 (Olympus, Japan) at room temperature and in an ambient atmosphere, and a magnification of 50 times was used. Static water contact angles were measured with a goniometer (Phoenix 300, Surface Electro Optics Co. Ltd., Korea) and recorded with a CCD camera. A grazing incidence Attenuated Total Reflection-Fourier Transform Infra-red (ATR-FT-IR) microspectrometer (Hyperion 3000, Bruker Optics Inc., Germany) was used to detect organic functional groups of P3HT film and aminosilane SAM. The ATR objective (a 45° polarized beam in the IR mode; magnification = 20x; resolution = 4 cm⁻¹; scan time = 64 times) used for the IR measurements is surface-sensitive enough to detect a functional group in a film as thin as ~50 nm. To measure a sheet resistance for the conductivity calculation, a four point probe (CMT-series, Changmin Co. Ltd., Korea) was used. All atomic force microscopic images were measured with a SPA 400 (Seiko, Japan; tapping mode, scan speed: 0.5 Hz, scan size: 30 × 30 μm). To evaluate the adhesion between the P3HT film and the SiO2 surface, a 3 M Scotch® tape test was carried out.

Results and Discussion

Static water contact angles on three different amino-functionalized propyltrimethoxysilane SAMs were measured and compared with previously reported values. The measured contact angles were 21°, 25°, and 39° for APS, EDAS, and DETAS monolayers, respectively. These values are fairly close to the previously reported ones of 22°, 28°, and 41° for APS, EDAS, and DETAS SAMs, respectively. In addition, to confirm the monolayer formation, X-ray photoelectron spectroscopic data were collected from the blanket-deposited amino-functionalized alkylsilane ultrathin films on a SiO2 surface. C 1s and N 1s peaks were commonly observed from all of the three films and the intensities of N 1s were in excellent agreement with the amounts of N 1s electrons escaped from the monolayers as reported in our previous publications. These obviously support that the amino-functionalized silane molecules form a smooth monolayer film.

To evaluate the adhesion between the P3HT nanofilm and the SiO2 surface, amino-functionalized alkylsilane (APS, EDAS, DETAS) monolayers were blanket-deposited on an oxidized Si wafer surface, and then immediately rinsed with methanol. To directly observe the adhesion improvement, a Scotch® tape test was carried out and the results are shown in Figure 1. The images show the tapes detached from perpendicularly scratched P3HT films. These images obviously indicate that, unlike the P3HT film on a bare SiO2 surface, the same film on amino-functionalized silane monolayers are not lifted off by tape at all. This result is very similar with the one from the PEDOT nanofilms grown on an APS SAM by VPP method. This clearly indicates that the amino-functionalized silane monolayers play a critical role in improving adhesion between the P3HT film and SiO2 surface, most likely through direct chemical bonding.

Figure 2 shows atomic force microscopic images of P3HT nanofilms line-patterned (~6.5 μm width) on amino-functionalized alkylsilane SAMs. These 3-dimensional images clearly indicate that P3HT nanofilms can be selectively deposited on the line patterns of amino-functionalized alkylsilane SAMs. In particular, the sharp edges and smooth lines

Figure 1. An adhesion test carried out in this study. Optical microscopic images of Scotch® tapes detached from various P3HT/aminosilane SAM surfaces. Please, note a P3HT film nearly completely comes off a bare SiO2 surface.
of P3HT patterns shown in all of the images visually confirm that the 3HT monomers have an outstanding selectivity for aminosilane SAM over OTS-SAM. This selectivity obviously originates from the selective and uniform wetting of a FeCl₃-dissolved solution on a hydrophilic aminosilane SAM surface. However, the highly acidic FeCl₃ solution (pH = ~1.0) does not wet a completely hydrophobic OTS-SAM surface at all. As a result, the 3HT monomers can polymerize and subsequently grow only on the FeCl₃-coated aminosilane SAM patterns. In fact, the polymerization of 3HT monomers was identified by an ATR-FT-IR Spectrometer (Hyperion 3000, Bruker Optics Inc., Germany). For example, the spectrum of a FeCl₃-doped P3HT complex on an APS SAM surface (Fig. 3) shows characteristic stretching vibrational bands due to conjugated C=C (~1500 cm⁻¹) and disappearance of stretching bands (3116 cm⁻¹) due to 2,5-hydrogens of thiophene rings, firmly supporting that the monomers were polymerized. Another undeniable evidence for the polymerization is conductivity (σ) values for the P3HT films. The conductivity was calculated using the equation \( \sigma = IS/Vd \), where \( I \), \( S \), \( V \), and \( d \) are an electrical current, applied voltage, area of cross-section of sample, and gap between electrodes, respectively. Table 1 shows conductivity values for 3 wt% FeCl₃-doped P3HT nanofilms on APS, EDAS, and DETAS SAMs. As shown, the conductivity values range from 0.49 S/cm to 0.55 S/cm. These values well match with the one (0.47 S/cm) measured from a solvent-casted crystalline P3HT film (2 wt% FeCl₃-doped, 110 μm thick film). This obviously supports that the P3HT nanofilms were indeed polymerized.

Another important issue for P3HT electrodes is the conductivity, itself. Around 0.5 S/cm of the conductivity (σ) values for vapor phase polymerized P3HT films is still far

Table 1. Conductivity of P3HT films

<table>
<thead>
<tr>
<th>P3HT (FeCl₃ dopant) Film thickness</th>
<th>Conductivity (S/cm)</th>
<th>Ref.</th>
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<tbody>
<tr>
<td>Solvent cast (2 wt% FeCl₃) 110 μm</td>
<td>0.47</td>
<td>[11]</td>
</tr>
<tr>
<td>Solvent cast (19 wt% FeCl₃) 15 μm</td>
<td>2.8 × 10⁻³</td>
<td>[12]</td>
</tr>
<tr>
<td>VPP on APS (3 wt% FeCl₃) 52 nm</td>
<td>0.487</td>
<td></td>
</tr>
<tr>
<td>VPP on EDAS (3 wt% FeCl₃) 55 nm</td>
<td>0.524</td>
<td></td>
</tr>
<tr>
<td>VPP on DETAS (3 wt% FeCl₃) 53 nm</td>
<td>0.549</td>
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Figure 3. ATR-FT-IR spectrum of a P3HT nanofilm on a FeCl₃-coated APS-SAM surface. Please note that the broad stretching vibrational band at ~3200 cm⁻¹ is due to hydrogen-bonded N-H groups on APS monolayer and the bands from 1300 cm⁻¹ to 1500 cm⁻¹ originate from conjugated C=C stretching vibration. This clearly indicates that the FeCl₃-doped film is a highly conjugated homo-polymer. The inset shows a magnified region for N-H and C-H stretching bands (2800-3600 cm⁻¹).
below the minimum value (~50 S/cm) required for a reliable organic electrode materials. This issue was foreknown by a couple of indications ascertained from the polymerization time and morphology of P3HT films. To reach nearly a 50 nm thick film, P3HT film was grown for 30 minutes via the VPP method. This polymerization time is roughly 20 times slower than the one (3 minutes for ~100 nm thick film) for the PEDOT growth by the same method.6,7 Such sluggish growth time of P3HT films means a low reactivity of 3HT molecules for the polymerization. Therefore, it is reasonable to conjecture that the polymerization does not proceed at large scale as the PEDOT does. In fact, the AFM images in Figure 2 show that the patterned P3HT morphology is not smooth after methanol washing which means that partly polymerized or only oligomerized tiny fragments easily come off the film surface. This phenomenon apparently supports the low reactivity of 3HT molecules upon polymerizing, and more importantly it at least in part explains why the P3HT films are not as conductive as the PEDOT films (500-600 S/cm). Nevertheless, better or comparable conductivity values (~0.5 S/cm) measured from much thinner VPP P3HT films (~50 nm) than solvent-casted crystalline P3HT films11,12 (Table 1) mean that the current much more effectively and quickly flows in parallel with the VPP film surface than with the thick solvent-casted films. This is a very desirable characteristic for the electrode materials of a TFT device where the current must run well through the electrode in parallel with the substrate surface. This evidently demonstrates that the VPP method is an excellent choice for effective doping. However, we were not able to pinpoint exactly why the wash-off happens at the moment and it is beyond the scope of the present study. Therefore, the P3HT growth mechanism needs to be elucidated in more detail for improving the quality of P3HT electrode materials and it is currently underway.

**Conclusion**

This study successfully demonstrated that a P3HT nanofilm can be highly selectively and finely patterned on an oxidized silicon wafer surface and strongly adhered to the substrate surface via the combination of a SAM technique and VPP method. In particular, it must be noted that this newly developed all bottom-up process could be a convenient and inexpensive patterning method for P3HT nanofilms, and this significantly heightens the possibility a highly effectively doped P3HT film can be employed as an electrode component of an OTFT device.

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**References**